

SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The μ PA1717 is P-Channel MOS Field Effect Transistor designed for power management applications of notebook computers.

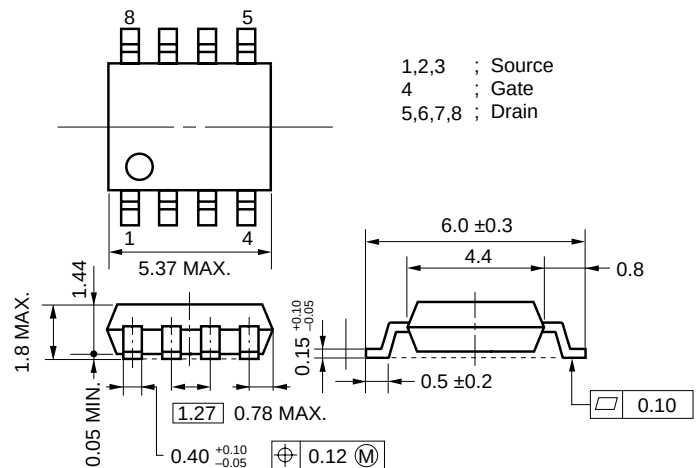
FEATURES

- Low on-state resistance
 $R_{DS(on)1} = 33 \text{ m}\Omega \text{ MAX. (V}_{GS} = -10 \text{ V, I}_D = -3 \text{ A)}$
 $R_{DS(on)2} = 59 \text{ m}\Omega \text{ MAX. (V}_{GS} = -4.5 \text{ V, I}_D = -3 \text{ A)}$
- Low C_{iss} : $C_{iss} = 830 \text{ pF TYP.}$
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA1717G	Power SOP8

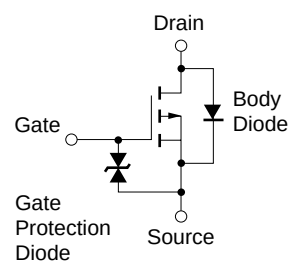
PACKAGE DRAWING (Unit : mm)



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, All terminals are connected.)

Drain to Source Voltage ($V_{GS} = 0\text{ V}$)	V_{DSS}	-30	V
Gate to Source Voltage ($V_{DS} = 0\text{ V}$)	V_{GSS}	∓ 25	V
Drain Current (DC)	$I_{D(DC)}$	∓ 6	A
Drain Current (pulse) ^{Note1}	$I_{D(pulse)}$	∓ 24	A
Total Power Dissipation ($T_A = 25^\circ\text{C}$) ^{Note2}	P_T	2.0	W
Channel Temperature	T_{ch}	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

EQUIVALENT CIRCUIT



Notes 1. $PW \leq 10 \mu s$, Duty Cycle $\leq 1 \%$

2. Mounted on ceramic substrate of $1200 \text{ mm}^2 \times 2.2 \text{ mm}$

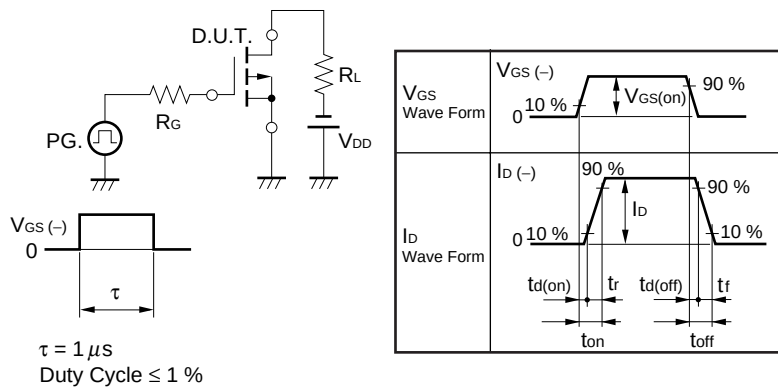
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

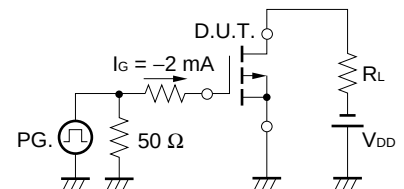
ELECTRICAL CHARACTERISTICS (T_A = 25 °C, All terminals are connected.)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	R _{DS(on)1}	V _{GS} = -10 V, I _D = -3 A		26	33	mΩ
	R _{DS(on)2}	V _{GS} = -4.5 V, I _D = -3 A		44	59	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.5	-2.0	-2.5	V
Forward Transfer Admittance	y _{fs}	V _{DS} = -10 V, I _D = -3 A	3.0	7.5		S
Drain Leakage Current	I _{DSS}	V _{DS} = -30 V, V _{GS} = 0 V			-1	μA
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ± 25 V, V _{DS} = 0 V			± 10	μA
Input Capacitance	C _{iss}	V _{DS} = -10 V		830		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V		330		pF
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		130		pF
Turn-on Delay Time	t _{d(on)}	I _D = -3 A		15		ns
Rise Time	t _r	V _{GS(on)} = -10 V		120		ns
Turn-off Delay Time	t _{d(off)}	V _{DD} = -15 V		70		ns
Fall Time	t _f	R _G = 6 Ω		50		ns
Total Gate Charge	Q _G	I _D = -6 A		15		nC
Gate to Source Charge	Q _{GS}	V _{DD} = -24 V		3		nC
Gate to Drain Charge	Q _{GD}	V _{GS} = -10 V		5		nC
Body Diode Forward Voltage	V _{F(S-D)}	I _F = 6 A, V _{GS} = 0 V		0.82		V
Reverse Recovery Time	t _{rr}	I _F = 6 A, V _{GS} = 0 V		35		ns
Reverse Recovery Charge	Q _{rr}	di/dt = 100 A / μs		15		nC

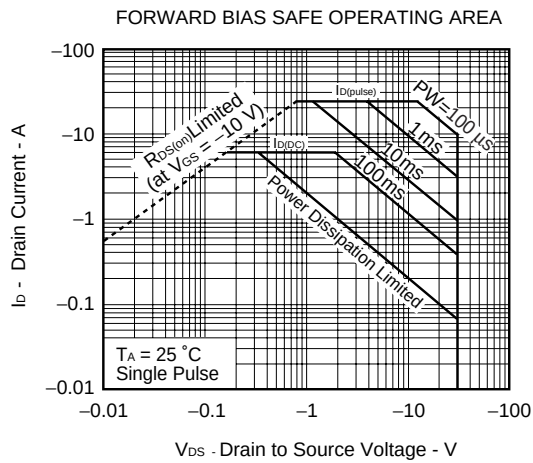
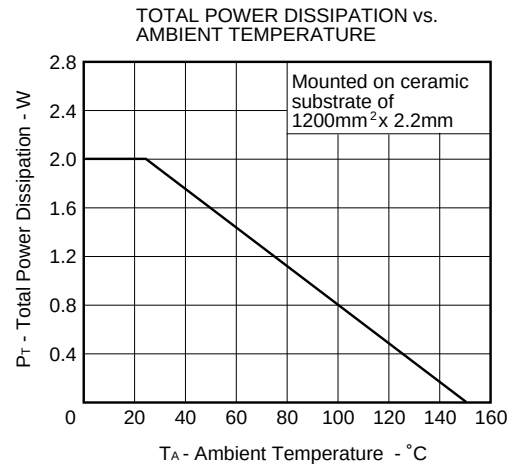
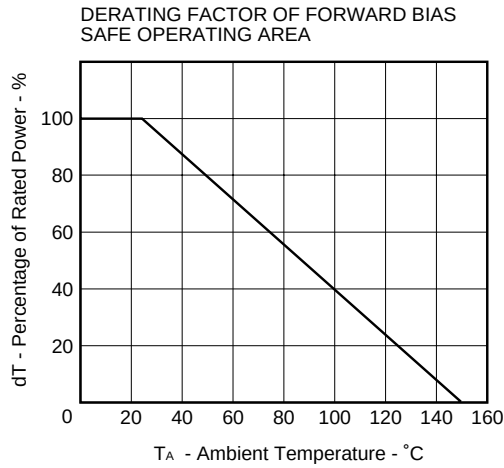
TEST CIRCUIT 1 SWITCHING TIME



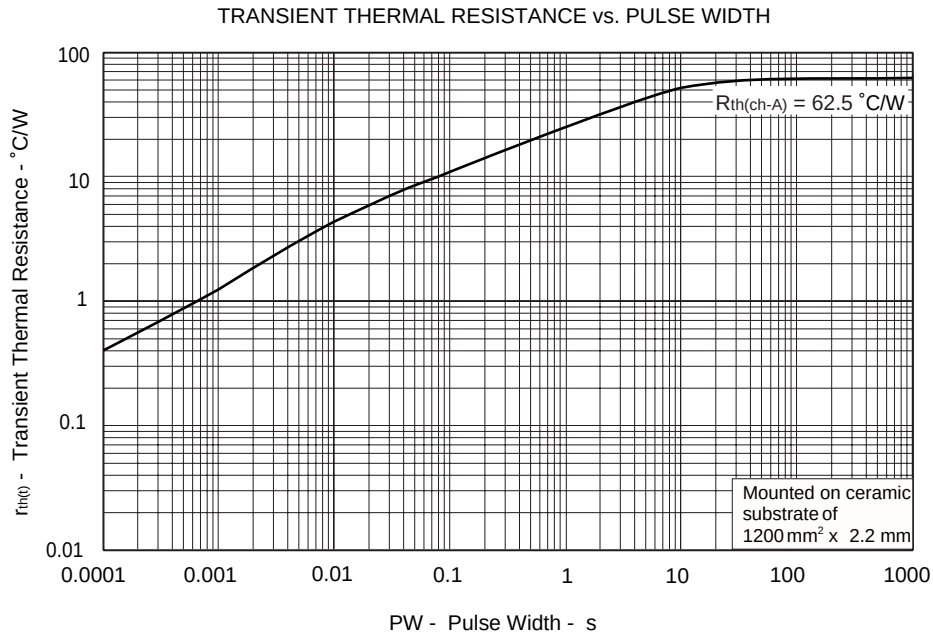
TEST CIRCUIT 2 GATE CHARGE

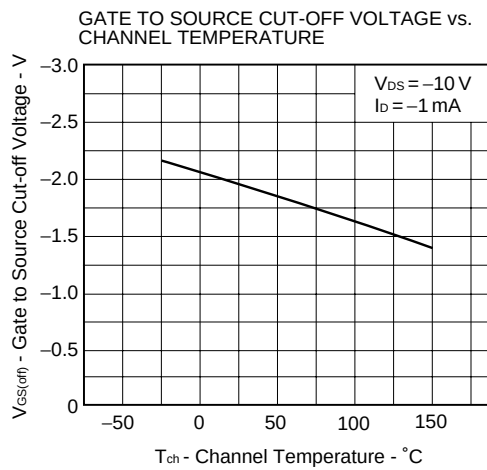
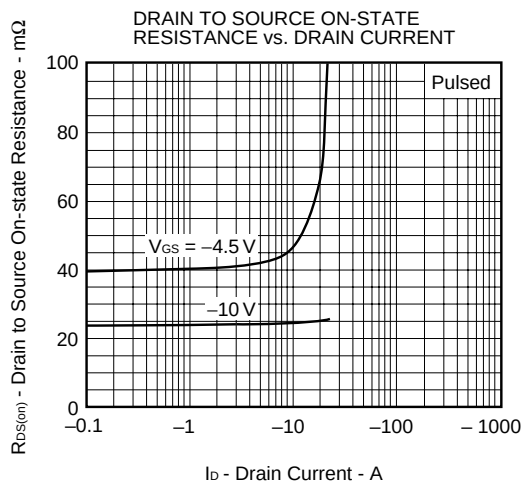
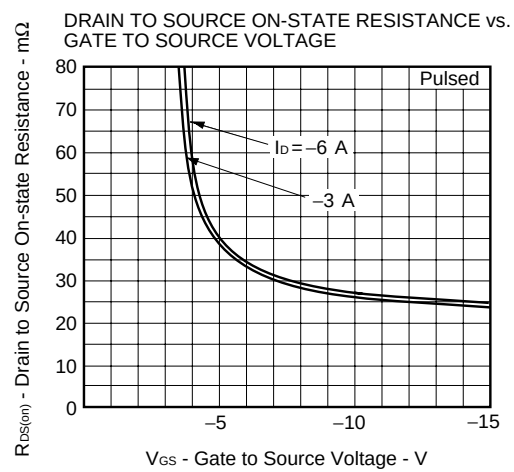
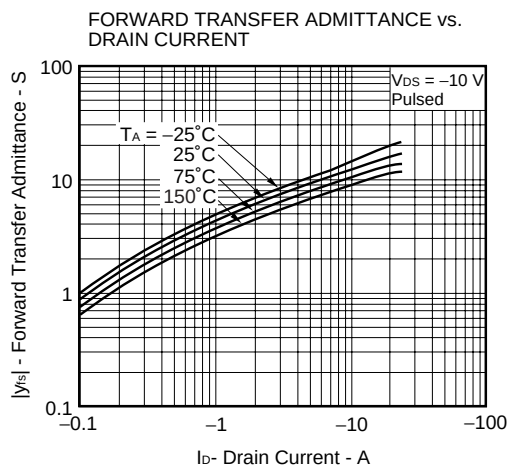
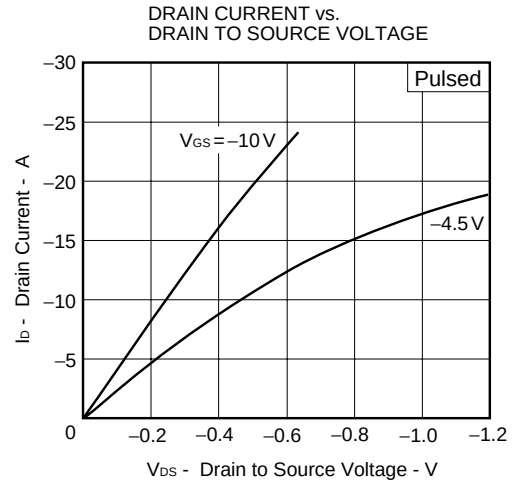
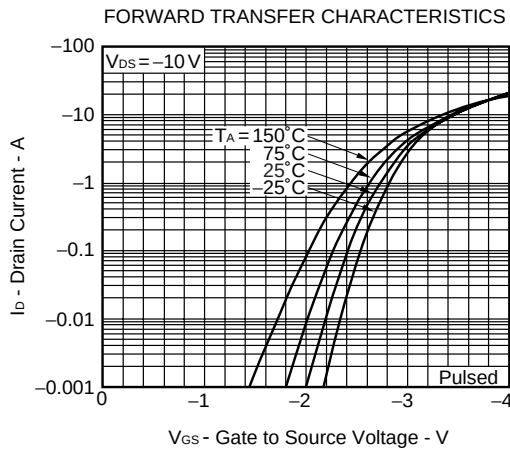


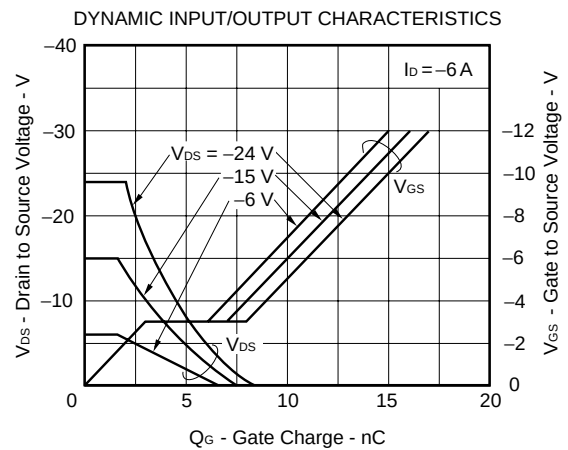
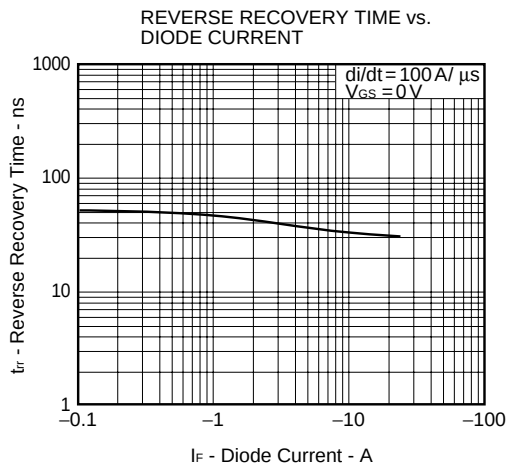
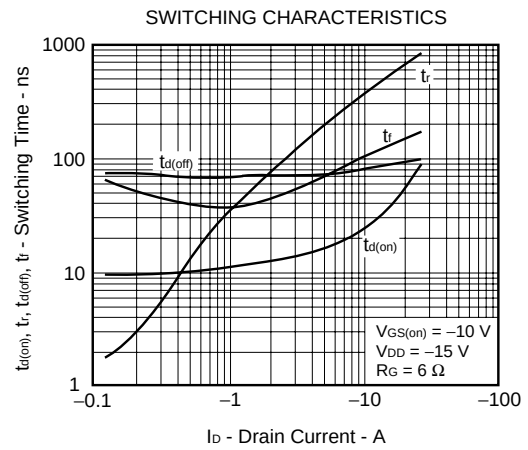
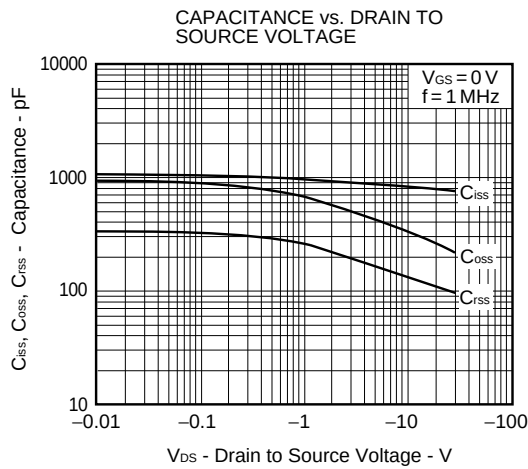
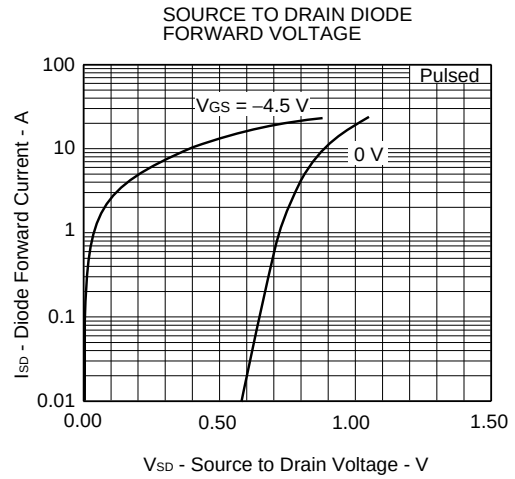
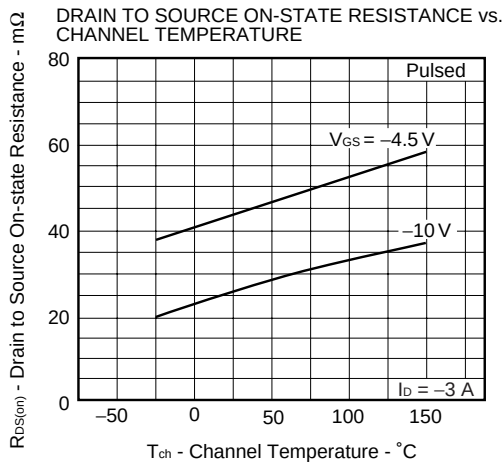
TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$)



Remark Mounted on ceramic substrate of $1200\text{ mm}^2 \times 2.2\text{ mm}$







[MEMO]

[MEMO]

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